



General Description

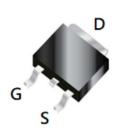
These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

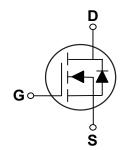
BV _{DSS}	R _{DS(ON)}	Ι _D
100 V	48 mΩ	30 A

Features

- $R_{DS(ON)} \leq 48 m \Omega @V_{GS} = 10V$
- · Improved dv/dt Capability
- Fast Switching
- · Green Device Available

TO-252 Pin Configuration





Applications

- · Automative Lighting
- · Load Switch
- · Uninterruptible Power Supply

Absolute Maximum Ratings T _c =25°C unless otherwise noted							
Symbol	Parameter	Rating	Units				
V_{DS}	Drain-Source Voltage	100	V				
V_{GS}	Gate-Source Voltage	±20	V				
I _D	Drain Current - Continuous (T _C =25°C)	30	Α				
I _{DM}	Drain Current - Pulsed (NOTE 1)	90	Α				
P_D	Power Dissipation (T _C =25°C)	34.7	W				
T_J	Operating Junction Temperature Range	-55 to 150	°C				
T_{STG}	Storage Temperature Range	-55 to 150	°C				
Marking Code		NM048					

Thermal Characteristics					
Symbol	Symbol Parameter Rating				
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	62.5	°C/W		
$R_{ heta JC}$	Thermal Resistance Junction to Case	3.6	°C/W		





Electrical Characteristics (T_J=25°C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	100			V
I _{DSS}	Drain-Source Leakage Current	V _{DS} =100V , V _{GS} =0V			1	uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} =±20V , V_{DS} =0V			±100	nA

On Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R _{DS(ON)}	IStatic Drain-Source On-Resistance	V _{GS} =10V , I _D =10A			48	mΩ
		V _{GS} =4.5V , I _D =6A			55	11122
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=250uA$	1.0		2.2	V

Dynamic and switching Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Q_g	Total Gate Charge			20		
Q_{gs}	Gate-Source Charge	V_{DS} =80V , V_{GS} =4.5V , I_{D} =20A		3.1		nC
Q_{gd}	Gate-Drain Charge			14		
$T_{d(on)}$	Turn-On Delay Time			11		
T_r	Rise Time	V_{DS} =80V , V_{GS} =4.5V , R_{G} =3.1 Ω , I_{D} =20A		91		nS
$T_{d(off)}$	Turn-Off Delay Time			40		113
T _f	Fall Time			71		
C _{iss}	Input Capacitance			1964		
C_{oss}	Output Capacitance	V_{DS} =25V , V_{GS} =0V , f=1MHz		90		pF
C_{rss}	Reverse Transfer Capacitance	7 [74		

Drain-Source Diode Characteristics and Ratings

<u> </u>						
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I _S	Continuous Source Current	V _G =V _D =0V , Force Current			30	Α
V_{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =20A			1.2	V
t _{rr}	Reverse Recovery Time	I _F =20A,di/dt=100A/us		64		nS
Q_{rr}	Reverse Recovery Charge			152		nC

NOTES:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 3. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.





Characteristics Curves

FIG. 1-Output Characteristics

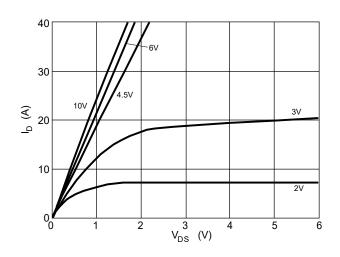


FIG. 2-Transfer Characteristics

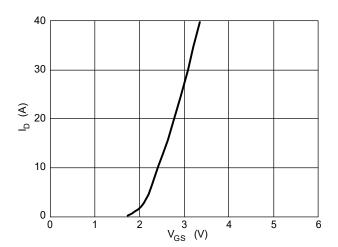


FIG. 3-R $_{\rm DS(ON)}$ vs. $I_{\rm D}$

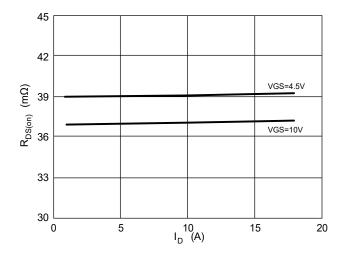


FIG. 4- I_S vs. V_{SD}

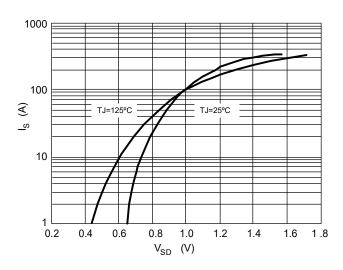


FIG. 5-Normalized BV_{DSS} vs. T_J

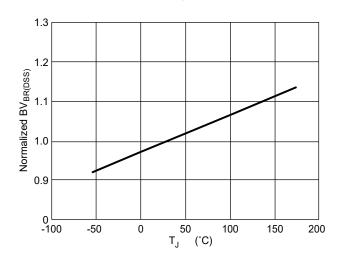
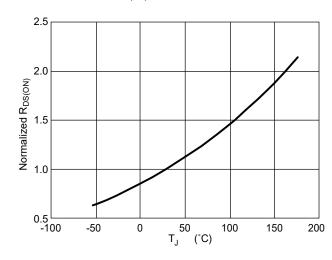


FIG. 6-Normalized R_{DS(ON)} vs. T_J







Characteristics Curves

FIG. 7-Switching Time Waveform

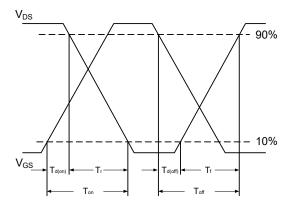
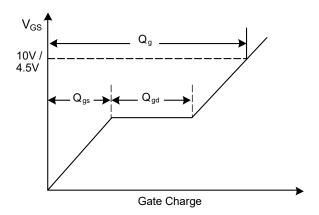
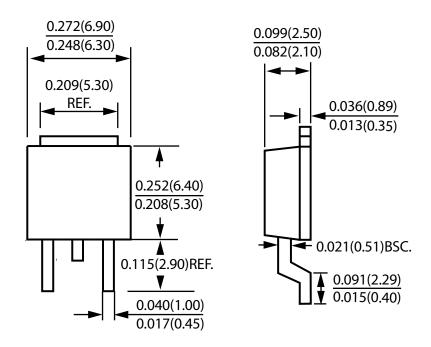


FIG. 8-Gate Charge Waveform



Package Outline Dimensions



TO-252
Dimensions in inches and (millimeters)





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